Current sense resistor - Gauge the flow of current Low value, high power

Step-down voltage regulator - Buck converter
Reduce input voltage to a desired lower level efficiently
High level of efficiency & Minimizing energy loss
Based on the principle of switching power supply systems
DC-to-DC converter - Transistor and a diode -> Switch on and off ->
Control flow of energy from input to output

 Duty cycle of switching transistor - Fraction of the total period for which the transistor is switched on - When transistor is on -> Energy stored in an inductor / When transistor is off -> Stored energy is released to the load - Effectively reducing the voltage

PG Power good
Open-drain output - Whether output within the correct range
Connect to microcontroller / Status LED

FB Feedback pin Voltage regulation - Set output voltage

EN Enable Turn the regulator on or off

SW Switch node
Switching output - High-frequency pulsed voltage
Latter regulated by an inductor
ON - MOSFET ON -> Connect SW to VIN - Current to build up in the inductor
OFF - MOSFET OFF -> Release stored energy

TPS62A01 - Step-down (buck) converter

High-efficiency synchronous buck converter

High input voltage -> Low stable output voltage - Minimal power loss Switching regulator - Rapidly switches an internal MOSFET to transfer

energy to output Input voltage - 2.3V - 5.5V

Output voltage 0.6V-4.8V

Maximum output current - 2A

Efficient - Up to 96%

Switching frequency - 2.4 MHz

Integrated MOSFET - Reduce external component count

5 Pin Configuration and Functions

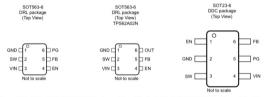


Figure 5-1. 6-Pin DRL SOT-563 Package (Top View), 6-Pin DDC SOT-23 Package (Top View)

Table 5-1. Pin Functions

	Pin Number		Type(1)	Description	
Name	SOT563-6	SOT23-6	турест	Description	
EN	4	1	1	Device enable logic input. Logic high enables the device. Logic low disables the device and turns the device into shutdown. Do not leave the pin floating.	
FB	5	6	1	Feedback pin for the internal control loop. Connect this pin to an external feedback divider.	
GND	1	2	G	Ground pin.	
PG	6	5	0	Power-good open-drain output pin. The pullup resistor cannot be connected to any voltage higher than 5.5V. If unused, leave the pin open or connect to GND.	
OUT ⁽²⁾		1	1	Output voltage sense pin.	
sw	2	3	0	Switch pin connected to the internal FET switches and inductor terminal. Connect the inductor of the output filter to this pin.	
VIN	3	4	1	Input voltage pin. Connect the input capacitor as close as possible between V_{IN} and $\mbox{GND}.$	

I = Input, O = Output, G = Ground.
 Only for TPS62A0xN versions.

LD57100JR

Low-dropout regulator (LDO) - DC linear voltage regulator Operate a small difference between input supply voltage and output voltage

High voltage -> Lower voltage - Ensure the voltage stability in a circuit Maintain a small voltage difference between the input voltage and output voltage - High efficiency

Power management - Stabilize output voltage levels Isolate loads from noisy power sources -> Low-noice power supplies -Sensitive electronic circuits

Ferrite bead 铁氧体磁珠 -> Anti-interference

Noise filtering & EMI suppression

Clean power delivery

Electrical function: Resemble an inductor - Frequency response deviates from this functionality at high frequencies

High impedance & Low permeability -> Power filtering

Better high-frequency filtering characteristics than ordinary inductors -> Resistance at high frequencies - Maintain a high impedance in a wide frequency range -> Improving the frequency modulation filtering effect

LDO

FB Feedback pin Voltage regulation - Set output voltage

VBIAS Bias voltage

Provide internal bias voltage - Improve efficiency / Lower dropout voltage

EN Enable

Turn the regulator on or off



Pin#	Symbol	Functions
A1	Vout	Output voltage
A2	VIN	Input voltage
В1	SNS / FB	Output voltage sense pin in fixed version. Connect to the load with a separate PCB track Feedback pin in adjustable version. Connect to the resistor divider central node
B2	EN	Enable pin logic input: low = shutdown, high = active
C1	GND	Common ground
C2	VBIAS	Bias supply input

ADC (HMCAD1511) - High-speed 8 / 10 bits ADC Used in RF Communications High-speed data acquisition systems Multi-channels Output - Differential digital signals

PLL module (Clock management Green box) Generate and condition ADC sampling clock Communicate through I^2C (SDA/SCL)

VCM Input common-mode voltage range
DC-coupled inputs + Single-supply power
Input signals fed to amplifier and ADC should be biased at a DC level within
the VCM range -> Eliminate a major barrier to amplifier and ADC design - Low
distortion + High linearity

Bias point - Operating point DC voltage / Current - Instantaneous value might vary

UFL connectors

Provide external clock inputs for ADC

ADC_CLK P/N - High-frequency clock input - From Low-jitter clock source (PLL or Oscillator)

External clocking - Synchronized sampling with the system's data processing unit (FPGA / DSP)

FCLK Frame clock

Synchronize data frame transmission from ADC to the processor / FPGA Ensure proper alignment of the digitized signals

LCLK Line clock

Control data word timing for each line of ADC output
Work in sync with FCLK to maintain data integrity + avoid timing errors

Both clocks are differential signals - Better noise immunity and reduced jitter

VCM Common-mode voltage bias point Midpoint reference voltage - Bias differential analog signal

Ensure input signals remain within ADC's optimal dynamic range Provide a stable DC bias for differential pairs - Signal integrity VCM - Provided by ADC - Connected to external component as to stabilize input signals

Capacitor (C134 100nF) - Decoupling - Reduce noise at the VCM node

Features of HMCAD1511

8-bit High Speed Single/ Dual/ Quad ADC Single Channel Mode: FSmax = 1000 MSPS Dual Channel Mode: FSmax = 500 MSPS Quad Channel Mode: FSmax = 250 MSPS Integrated Cross Point Switches (Mux Array)

1X to 50X digital gain

No missing codes up to 32X

1X gain: 49.8 dB SNR 10X gain: 48.2 dB SNR

Internal low jitter programmable Clock Divider

Ultra Low Power Dissipation

710 mW including I/O at 1000 MSPS

 $0.5~\mu s$ start-up time from Sleep, $15~\mu s$ from Power Down Internal reference circuitry with no external components required Coarse and fine gain control Digital fine gain adjustment for each ADC Internal offset correction

1.8 V supply voltage

1.7 - 3.6 V CMOS logic on control interface pins

Serial LVDS/RS DS output

7x7 mm QFN 48 Pin (LP7D) Package

Bias point - Operating point -> Ensure signals stay within operating limits Steady-state voltage or current - Proper operation of active component - Transistors / Amplifier / ADC input stages

PCIe edge connector (P1)
PCIe x4 interface - Power Data transmission Control signals
Differential TX and RX lanes for PCIe Gen 1/2/3/4 speeds - Data transfer
High-speed serial communication - Reduced noise & Interference

Reference clock - REFCLK 100MHz PCIe clock Reset control - RERST# Presence detection - PRSNT

ADM7171ACPZ-5.0

Low-dropout (LDO) linear regulator - Manipulated by Analog devices High accuracy, Low noise, High power supply rejection ratio Powering High-speed ADCs DACs PLLs RF circuits High-speed FPGA and DSP power rails

Fixed output voltage - 5.0V Input voltage range - Up to 6.5V Maximum output current - 500mA

LM27761 85%

Charge pump inverter - Generate -5V from 5.2V

Low-noise inverting charge pump - Regulated negative output voltage Generate a stable negative voltage from single positive supply

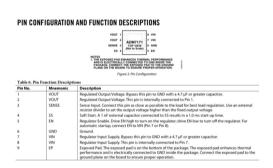
Low-power + Noise-sensitive applications

Input voltage range - 2.7V - 5.5V

Output voltage - Adjustable negative voltage (Up to -5V)

Output current - Up to 250mA

Efficiency - Up to 85%





PIN		TYPE(1)	DESCRIPTION	
NUMBER	NAME	TTPE	DESCRIPTION	
1	VIN	P	Positive power supply input.	
2	GND	G	Ground	
3	CPOUT	Р	Negative unregulated output voltage.	
4	VOUT	P	Regulated negative output voltage.	
5	VFB	Р	Feedback input. Connect VFB to an external resistor divider between VOUT and GND. DO NOT leave unconnected.	
6	EN	1	Active high enable input.	
7	C1-	P	Negative terminal for C1.	
8	C1+	Р	Positive terminal for C1.	
_	Thermal Pad	G	Ground, DO NOT leave unconnected.	

DC_CPL DC coupling control
Configure whether AC or DC coupling is used

PGA_CSn, PGA_SCLK, PGA_SDIO SPI interface for controlling the PGA settings

TRIM

Calibration or fine tuning for gain and offset

Multi-channel programmable gain amplifier (PGA) front-end system Analog signal acquisition & conditioning & processing -sent to-> ADC

Differential output (OUT P / OUT N) - High-speed + Low-noise differential format

Controlled via SPI (PGA_CSn, PGA_SCLK, PGA_SDIO) -> Adjustable gain settings

Amplifiers with adjustable multiples

OP07CDR

Precision operational amplifier - Voltage buffer -> Bias generation Low-impedance + Noise-free bias source

Low-impedance + Noise-free bias source

Low-offset + High-precision operational amplifier (op-amp) -> High-

accuracy signal processing applications
Ultra-low input offset voltage + Low-drift + High common-mode rejection

Low input offset voltage - 75µV (max)

Low input bias current - 1.8nA

Low noise

High common-mode rejection ratio 120dB

High open-loop gain - 100dB

Wide supply voltage range - +-3V - +-18V / 6V - 36V

Package type - SOIC-8 (CDR suffix)

ADC front-end buffers

Generate stable bias voltage

TPS7A2033 - 3.3V LDO linear voltage regulator

Power stabilization + Low noise
Powering low-power digital circuits
Output voltage - 3.3V
Input voltage range - 2.7V to 6.5V
Maximum output current - 200mA
Low dropout voltage
Low quiescent - 31µA
Package - SOT-23

	PIN			
NAME	X2SON	SOT-23	I/O	DESCRIPTION
IN	4	1	-	Input voltage supply. For best transient response and to minimize input impedance, use the nominal value or larger capacitor from IN to ground as listed in the Recommended Operating Conditions table. Place the input capacitor as close to the IN and GND pins of the device as possible.
OUT	1	5	٥	Regulated output voltage. A low equivalent saries resistance (ESR) capacitor is required from OUT to ground for stability. For best transient response, use the nominal recommended value or larger capacitor listed in the Recommended Coperating Conditions table. Place the output capacitor as does to the OUT and Coperating Conditions table. Place the output capacitor as does to the OUT and coperating the Commended Coperating Conditions table. Place the output capacitor as does to the OUT and coperating the Coperating Conditions and Coperating Cope
EN	3	3	1	Enable input. A low voltage ($<$ V _{ENLOW,}) on this pin turns the regulator off and discharges the output pin to GND. A high voltage ($>$ V _{ENPH}) on this pin enables the regulator output. This pin has an internal SOKID pulldown resistor to hold the regulator off by default. When V _{EN} $>$ V _{ENPH} , the SONLQ pulldown is disconnected to reduce input current.
GND	2	2	-	Common ground.
N/C	-	4	-	No internal electrical connection.
Thermal Pad	5	-	-	Thermal pad for the X2SON package. Connect this pad to GND or leave floating Do not connect to any potential other than GND. Connect the thermal pad to a large-area ground plane for best thermal performance.

MCP4432T-503E - Qual-channel Digital potentiometer I^2C-controlled - Adjustable resistance trimming Resistor taps - 128 position (7-bit resolution) Resistance options - $5k\Omega$ $10k\Omega$ $50k\Omega$ $100k\Omega$ Operating voltage 1.8V to 5,5V Wiper Non-volatile memory (EEPROM) - Retain settings after power los

MCP4728 - Qual-channel DAC
4-channel 12-bits DAC
I^2C-controlled -> Precise analog voltage trimming / generation
Resolution - 12-bit (4096 discrete voltage levels)
Output voltage - Configurable (Buffered)
Operating voltage - 2.7V to 5.5V
Non-volatile memory (EEPROM) - Store DAC settings

DMN62D0UW - MOSFET -> Level shifting

3.0 PIN DESCRIPTIONS

The descriptions of the pins are listed in Table 3-1.

Pin No.	Name	Pin Type	Function
1	V _{DD}	Р	Supply Voltage
2	SCL	OI	I ² C Serial Clock Input (Note 1)
3	SDA	01/00	I ² C Serial Data Input and Output (Note 1)
4	LDAC	ST	This pin is used for two purposes: (a) Synchronization Input. It is used to transfer the contents of the DAC input registers to the output registers (V _{OUT}). (b) Select the device for reading and writing I ² C address bits. (Note 2)
5	RDY/BSY	00	This pin is a status indicator of EEPROM programming activity. An external pull-up resistor (about 100 k Ω) is needed from RDY/BSY pin to V _{DD} line. (Note 1)
6	V _{OUT} A	AO	Buffered analog voltage output of channel A. The output amplifier has rail-to-rail operation.
7	V _{OUT} B	AO	Buffered analog voltage output of channel B. The output amplifier has rail-to-rail operation.
8	V _{OUT} C	AO	Buffered analog voltage output of channel C. The output amplifier has rail-to-rail operation.
9	V _{OUT} D	AO	Buffered analog voltage output of channel D. The output amplifier has rail-to-rail operation.
10	V _{SS}	Р	Ground reference.

Legend: P = Power, OI = Open-Drain Input, OO = Open-Drain Output, ST = Schmitt Trigger Input Buffer,

AO = Analog Output

Note 1: This pin needs an external pull-up resistor from V_{DD} line. Leave this pin float if it is not used.

2: This pin can be driven by MCU.

Attenuation - Loss in signal strength

BNC connector (Bayonet Neill-Concelman)
Coaxial connector - Radio frequency connection
Quick and secure connections in various electronic and networking applications

Provide input / output for high-frequency signals

Relay

Electrically operated switch - One circuit to control another circuit Switch the signal path between direct transmission / attenuation

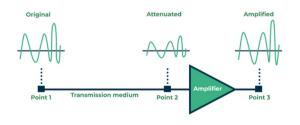
MOSFET transistor Metal Oxide Semiconductor Field-Effect Transistor Field-effect -> Switching and amplifying signals Structure - Source Drain Gate Body Function - Voltage - Gate controls -> Conductivity between source and drain - Efficient control of electrical current Switch -> Control relay activation

Protection diode

Two-terminal electronic component -Conduct current in one direction Protect circuit & Transforming AC into DC Prevent voltage spikes

Relays toggle between direct signal transmission and attenuation Transistors and diodes manage relay control and protection Capacitors and resistors ensure proper. Impedance matching

Attenuation	Amplification
It is the reduction in signal strength as it propagates from source to destination.	It is the method to increase the signal strength to compensate the loss of signal.
It is a passive process which occurs naturally due to intrinsic and extrinsic factors.	It is a active process which occurs through the use of amplification devices.
It causes signal degradation, data loss and limits range.	It results in enhanced signal quality, data reliability and improved range by overcoming attenuation.
It happens because of interference, scattering, absorption, bending losses.	It is done using signal boosters, amplifiers, repeaters.



DMN62D0UW MOSFET transistor
N-channel enhancement-mode MOSFET
Low-voltage switching application
Maximum Drain-Source Voltage - 20V
Continuous Drain Current - 1.5A
Low on-resistance ~0.1Ω
Grate threshold voltage - 0.6V~1.5V

1N4148 - Fast switching diode
High-speed Si switching diode - Signal processing & Protection circuit
Maximum Drain-source voltage - 100V
Forward current - 300mA
Forward voltage drop ~0.7V at 10mA
Switching speed 4ns
Package - DO-35
Limiting voltage spike

BSS84

P-channel MOSFET Switching applications in low-voltage power control circuit Maximum Drain-source voltage - 50V Continuous Drain current - 130mA On-resistance - 10Ω Grate threshold voltage -0.8V to -2V Package - 50T-23

FTR-B3SA4.5Z - Signal relay
Series - FTR-B3 (Subminiature Signal Relay)
Coil voltage - 4.5V DC
Contact form - SPST-NO (Single Pole Single Throw)
Coil type - Non-latching
Contact rating - Up to 1A at 30V DC / 0.5A at 125V AC
Features:

- · High sensitivity
- Small size
- Designed for signal switching
- Low power consumption

OP07C/RC - Amplify voltage Precision amplifier for signal conditioning Low-offset precision op-amp High-accuracy signal processing Control signal path

- · Amplification Boosting signal strength
- Mathematical operations Analog computer
- Oscillators and waveform generation
- Filtering Shaping the frequency spectrum
- Comparison Detecting voltage level

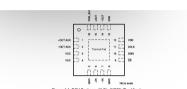
LMH6518

Digitally controlled variable gain amplifier (VGA) Adjust signal gain dynamically Control signal path

BNC / UFL connector High-frequency signal input / output

Biasing circuit(R_bias C_bias Voltage divider) Biasing network for op-amp and amplifier circuits Provide stable reference voltage for amplifier

SPI/I^2C control signal (SDA SCLK SDIO SDO)
Digital programmability
Allow Dynamic gain adjustment



	PIN	TYPE(I)	DESCRIPTION			
NO.	NAME	TYPE	DESCRIPTION			
1	+OUT AUX	0	Auxiliary positive output			
2	-OUT AUX	0	Auxiliary negative output			
3	VCC	P	Analog power supply			
4	VCC	P	Analog power supply			
5	GND	G	Ground, electrically connected to the WQFN heat sink			
6	+84	1	Positive input			
7	-IN	1	Negative input			
8	GND	6	Ground, electrically connected to the WQFN heat sink			
9	ČS	1	Serial chip select (SPI, active low): While this signal is asserted, SCLK is used to accept serial data present on SDIO and be source serial data on SDIO. When this signal is deasserted, SDIO is ignored and SDIO is in a high-impedance state.			
10	SDIO	ю	Serial data-in or data-out (SPI). During a write operation, serial data are shifted into the device (4-bit command and 16-bit data) on this privable CS signal is asserted. During a read-operation, serial data are shifted out of the device on this priva while CS signal is asserted. Another times, and after one complete access cycle (24-bits, see Figure 6-1 and Figure 6-2), his input is ignored. This output is in a high-importance state when CS is dessessed. This price bit biddectoral.			
11	SCLK	1	Serial clock (SPI): Serial data are shifted into and out of the device synchronous with this clock signal. SCLK transitions with CS deasserted are ignored. To minimize digital crosstalk, step SCLK when not used.			
12	VDD	P	Digital power supply			
13	VCM	1	Input from ADC to control main output common mode (CM) voltage			
14	-OUT	0	Main negative output			
15	+OUT	0	Main positive output			
16	VCM_AUX	1	Input to control auxiliary output CM voltage			
Pad	Thermal Pad	-	Thermal pad (WQFN heat sink), electrically connected to pins 5 and 8 (GND)			

VGA Variable Gain Amplifier - Voltage-Controlled Amplifier Adjust its gain based on a control voltage Function - Vary amplification level according to a control signal -> Flexible signal strength management

Signal conditioning

Electronic circuit -> Manipulation of an analog signal to prepare for further processing / measurement / transmission -> Improve accuracy + reliability - Suitable for subsequent stage

RF application Radio frequency

Enable wireless transmission and reception of information over airwaves for seamless communication

BUF802 Wideband Buffered Operational Amplifier

High-speed, wideband buffer amplifier

-> Low noise / High bandwidth / High slew rate

Signal conditioning / RF application

High bandwidth >2GHz -> High-speed analog applications

Low input bias current

Low noise

High slew rate -> Fast signal transitions

Wide supply voltage range +-2.5V to +-6.5V (Dual supply) / 5V to 13V (Single supply)

Can be used as a Buffer / Active gain configuration

Integrated ESD protection - Protect against electrostatic discharge -Reliability in sensitive circuits

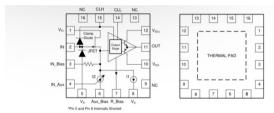


图 5-1. RGT Package, 16-Pin VQFN (Top View and Bottom View)

表 5-1. Pin Functions

F	PIN	TYPE(4)	Operating	DECORPTION
NAME	NO.	ITPE	Mode ⁽¹⁾ (2)	DESCRIPTION
Aux_Bias	6	Р	CL	Connect to V _S . to enable control of OUT through the In_Aux.
CLH	15	1	BF, CL	Input pin for setting positive clamp voltage
CLL	14	1	BF, CL	Input pin for setting negative clamp voltage
IN	2	1	BF, CL	Signal input
In_Aux	4	1	CL	Auxiliary input for controlling OUT through an external amplifier.
In_Bias	3	1	CL	JFET biasing pin
NC	16, 13, 9	-	_	Do not connect.
OUT	-11	0	BF, CL	Signal output
R_Bias	7	1	BF, CL	Output stage bias current setting pin
V _{S+}	1	P	BF, CL	Positive power supply connection for Input Stage.
Vs.	5, 8	Р	BF, CL	Negative power supply connection for Input Stage. Pin 5 and Pin 8 are internally shorted.
V _{SO+} (3)	12	Р	BF, CL	Positive power supply connection for Output Stage.
V _{SO-} (3)	10	P	BF, CL	Negative power supply connection for Output Stage.
Thermal Pac	i	_	_	The thermal pad is electrically isolated from the die and pins. Connect the thermal pad to any potential.

⁽¹⁾ See 1) 8.4 for more information on Buffer Mode (BF) and Composite Loop Mode (CL) functional modes.

(2) Pins specified as CL should only be used when operating in Composite Loop Mode and left floating when operating in Buffer Mode.

(3) V_{SO} and V_S should be left to the same potential since they are internally connected to each other through back-to-back diodes.

(4) Output: Power NC on connect.

TS12A4516 Analog switch

Single-pole, single-throw (SPST) analog switch Normally Open (ON)

-> Low-voltage + High-speed signal switching application CMOS technology - Low power consumption + Low ON resistance Operating voltage - 1.65V - 5.5V - Low-power application ON resistance - 1.5 Ω typical - Minimal signal loss

- Fast switching time
- Turn-on time 23nsTurn-odd time 18ns

Low leakage current - Signal integrity when switch is off Low power consumption - CMOS - Reduce overall power usage Package option - Available in small SOT-23 / SC-70 packages for compact circuit designs

- · Enable / disable a signal path
- · Controlled by a logic signal
- Low ON resistance Minimal signal distortion / attenuation
- Fast switching time Suitable for high-speed signal application

			MIN	MAX	UNIT
V ₊	Supply voltage range	-0.3	13	V	
V _{NC} V _{NO} V _{COM}	Analog voltage range ⁽³⁾	V0.3	V ₊ + 0.3	٧	
V _{IN}	Logic input range	V0.3	V+ + 0.3	V	
	Continuous current into any terminal		±20	mA	
	Peak current, NO or COM (pulsed at 1 ms, 1		±30	mA	
	ESD per method 3015.7		>2000	V	
	0 1 7 700	8-pin SOIC (derate 5.88 mW/°C above 70°C)		471	
	Continuous power dissipation (T _A = 70°C)		571	mW	
TA	Operating temperature range	-40	85	°C	
T _{stg}	Storage temperature range		-65	150	°C
	Lead temperature (soldering, 10 s)			300	°C

⁽¹⁾ Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under 'recommended operating conditions' is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

⁽²⁾ The algebraic convention, whereby the most negative value is a minimum and the most positive value is a maximum

(3) Voltages exceeding V, or GND on any signal terminal are claimed by internal diodes. Limit forward diode current to maximum

⁽³⁾ Voltages exceeding V_{*} or GND on any signal terminal are clamped by internal diodes. Limit forward-diode current to maximum current rating.

DC_CTRL DC control signal

Digital control signal - Enable or disable a circuit function

A control signal - Enable / disable part of the circuit

- Turn on / off a transistor or MOSFET switch
- · Activating / Deactivating an analog switch
- Controlling a relay or power gate

High signal (logic 1 /3.3V or 5V) - Turn ON a circuit

Low signal (logic 0 / 0V)- Turn OFF a circuit

Control signal to turn the MOSFET on / off

AVSEE Power rail / Analog voltage reference

- Analog voltage supply
- Reference voltage
- Low-noise analog power

Analog voltage supply or reference used in signal processing circuit - Powering op-amps / Analog signal paths

Likely an analog or auxiliary power source

Mounting hole

Chassis grounding and mechanical mounting points for PCB stability and Electromagnetic interference EMI shielding

Connected to GND for EMI shielding

MGT_TXx_P/N & MGT_RXx_P/N

High-speed differential TX / RX signals for PCIe

PERx P/N & PETx P/N

PCIe Transmit and Receive lanes

Transmitting and receiving high-speed data - High-speed communication

PERx REFCLK P/N

Reference clock signal to synchronize data transmission

M2 X4 TX & M2 X4 RX

PCIe signal lanes for M.2 interface

M.2 PCIe interface

High-speed connector standard -> Compact storage and expansion device Support multiple protocols - PCIe / SATA / USB3.0/2.0

Connector keying - 75-pin edge connector - Multiple key notches

Key types

- M-key SSD
- B-key WWAN
- A+E key Wi-Fi

High-speed data transfer

- PCIe Gen 3.0 x4 3.94GB/s
- PCIe Gen 4.0 x4 7.88GB/s
- PCIe Gen 5.0 x4 15.75GB/s

Low power consumption & Efficiency - Support Active State Power Management ASPM

PCIe - Peripheral Component Interconnect Express High-speed serial communication interface

- Differential signaling Noise-resistant high-speed data transfer
- Support multiple generation Increasing bandwidth

Lane based architecture - Differential pairs -> Lanes

Point-to-point topology (No bus sharing)

- Communicate directly to root complex (CPU / chipset)
- X share bandwidth & Each device gets dedicated lanes

Backwards compatibility - PCIe 4.0 can work with PCIe 3.0 slot

ADC differential pairs
High-speed ADC input channels for data acquisition

Merged SPI buses - PGA_SDI / PGA_SCLK / PGA_CSn SPI communication for configuring PGAs and ADCs

Joint Test Action Group JTAG header

Standardized debugging + testing + programming interface - Communicate with digital ICs (FPGAs Microcontrollers(MCU) CPUs)

Programming - Flash firmware onto FPGAs MCUs CPLDs

Debugging - Real-time debugging breakpoints and register access in processors

Boundary scan testing - Board-level testing

Debugging and programming interface for an FPGA / microcontroller

Hermaphroditic connector - High-density board interface Connector can mate with itself - Eliminate the need for male and female connector

High-density connectors for interfacing with baseboards / expansion modules

Self-mating design - No need for separate male / female parts
Reduce inventory complexity - One connector type fits both end
High-density board-to-board connectors -> ADC differential signal routing
SPI clock signal

TPS7A2025 - LDO regulator - 3.3V to 2.5V

Low-noise stable efficient power source -> Clean power for LVDS signaling

Output voltage - Fixed 2.5V

Input voltage range - 2.7V to 6.5V

Maximum output current - 300mA

Low quiescent current - 25µA

High power supply rejection ratio (PSRR)

Ultra-low noise - 14µV RMS(10Hz-100kHz) - High-precision analog

Package option - 5-pin package

M.2 key M interface

PCIe-based NVMe SSDs / High-speed expansion cards

Custom pinout for an M.2 connector -> Communication between the main board and an M.2 device

Support PCIe NVMe SSDs - PCIe x4 lanes -> High-speed data transfer Pin layout & keying - Different keying notches

M.2 key M connector

Main physical interface for connecting an M.2 device

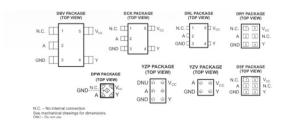
Pin count - 75-pin edge connector

Support PCIe x4 lanes - Faster

Usage - NVMe SSDs Al accelerators High-speed PCle cards

PERx_P/N (PCIe transmit / receive pairs)
High-speed data lanes for PCIe communication

REFCLK_P/N (Reference clock) Provide timing reference for PCIe transaction



	Pin Functions								
		PIN							
NAME	DBV, DCK, DRL, DPW	DRY, DSF	YZP	YZV	DESCRIPTION				
NC	1	1, 5	A1, B2	1-1	Not connected				
A	2	2	B1	A1	Input				
GND	3	3	C1	B1	Ground				
Y	4	4	C2	B2	Output				
Vcc	5	6	A2	A2	Power terminal				

Front end (Analog input stage) -> Signal conditioning

- Differential signal outputs <- Analog front-end circuit (AFE) -Process analog sensor data before conversion
- VCM Reference voltage -> Differential signal processing
- SPI SCLK / SDIO / PGA control signal Configuring PGA

ADC - Digitizing data

- REFINOUT Reference voltage connection
- SPI control signals-> ADC configuration + operation
- I^2C lines -> Controlling a phase-locked loop (PLL) circuit Clock synchronization

FPGA module - Real-time computation

- TE0712 (FPGA board) System-on-module (SOM) FPGA board -> High-speed data processing
- High-speed differential signal line Connecting ADC to FPGA
- Clock signals -> Synchronizing ADC data
- ACQ_EN / OSC_OE Control signals -> Requisition and clock management

M.2 interface -> High-speed data transfer to a host system

- M2_TX/RX High-speed communication lines for an M.2 device
- M2_GPIO General-purpose I/O pins -> Additional control

Analog front-end (AFE) circuit Process analog signals --> Digital form by ADC Functions:

- Amplification Boost weak signals Op-amp / PGA
- Filtering Remove unwanted noise and interference Filters
- Impedance matching Proper signal transfer Sensor & Processing circuits
- Signal conditioning Offset correction + Attenuation + DC biasing
- Differential to singe-ended conversion Differential signals -> Single-ended signals - Easier processing

Phase-locked loop (PLL) circuit

Feedback control system - Stable, synchronized output clock signal - Locking onto the phase of an input signal

Components:

- Phase detector (PD) Phase difference between the input signal & PLL output
- Low-pass filter (LPF) Filter out high-frequency noise from phase detector
- Voltage-controlled oscillator (VCO) Output signal Frequency is adjusted based on the phase error
- Frequency divider Adjust the output frequency by dividing it down to match the reference signal

System-on-module (SOM) FPGA board Simplify FPGA-based development - Ready-to-use platform Pros:

- Modular design Easily integrate into custom hardware
- Pre-validated hardware Reduce development time Providing test components
- Scalability Upgrading to more powerful FPGAs

BNC connector

Coaxial RF connector - Signal transmission

- Bayonet locking mechanism Stable connection + Prevent accidental disconnection
- Frequency range 4GHz
- Coaxial design Shielding against interference and signal loss
- · Versatile usage Support analog and digital signals

Allowing connection of oscilloscope probes

- SYNC1 Synchronization signal output for external measurement
- REFINOUT1 Distribute a reference output voltage for synchronization

TPD1E10B04 Transient voltage suppression TVS diode

Used for Electrostatic discharge (ESD) protection

Prevent voltage spikes from damaging sensitive electronic circuits

- Low capacitance ~0.55 pF Protecting high-speed signal
- ESD protection IEC 61000-4-2 standard Withstand +-25 kV air discharge + +-15 kV contact discharge
- Low leakage current ~10nA max Minimal power loss
- Unidirectional protection Clamp voltage spikes above a safe threshold

SYNC1

Synchronization signal output -> Timing alignment between multiple devices

- · Clock synchronization Multiple-system operation
- Triggering events Trigger oscilloscope measurements / test equipment
- Data alignment Phase-coherent data acquisition

REFINOUT1 - Reference signal output

Provide stable reference voltage / frequency for calibration + synchronization Functions:

- Voltage reference distribution Share a common reference voltage with multiple circuits
- Clock reference Frequency reference for PLLs or ADCs
- Stabilizing measurement systems Same voltage reference to reduce measurement error

 $R1 - 0\Omega$

Zero-ohm resistor - Jumper for flexibility in PCB design - Can be replaced

SN74LVC1G17 - Schmitt trigger buffer Single Schmitt-trigger inverter - 74LVC1G17

Clean up noisy / slow input signals <- Hysteresis (滞后现象) - Well-defined digital output

Features:

- Schmitt trigger action Hysteresis Different threshold voltages for high-to-low & low-to-high transitions -> Clean noisy / slow signal
- Wide operating voltage 1.65V to 5.5V
- Fast propagation delay 4.6 ns
- Low power consumption CMOS technology Low power operation
- Output drive strength Source / sink up to 32mA

Functionality:

- Input signal processing Noisy slow analog-like signal -> Sharp digital output
- Hysteresis effect Input voltage rises above a certain threshold -> HIGH & Input voltage falls below a lower threshold -> LOW - Prevent unwanted switching - Noise

10MHz crystal oscillator Stable reference clock for the PLL Precise clock source -> Timing-sensitive application Frequency - 10MHz

Low phase noise & jitter - Essential for high-precision timing circuits High stability - Consistent clock signals over varying temperature and voltages

ZL30260LDG1 - High-performance clock management and distribution IC Generate and distribute precise clock signals for ADC synchronization Clock inputs - External crystal oscillators (10MHz reference clock) Clock outputs - Multiple synchronized clocks for ADCs FPGAs Processors I^2C / SPI interface - Configuration via software Jitter attenuation & Frequency translation - Reduce timing error for clock signals

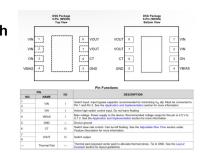
Power supply - 3.3V and 1.8V (dual supply)

Pin#	Name	Type	Description
15, 16 18, 19 20	IC1P, IC1N IC2P, IC2N IC3P		Input Clock Pins Differential or Single-ended signal format. Programmable frequency. Differential Sea Table 6 for electrical specifications, and see Figure 15 for recommended external circuity for interfacing these differential inputs to LVDS. LVPECL, CML or HSCL output pins on neighboring devices. Single-ended For prior signal amplitudes 22-8V, concerned the signal feedly for ICDP pin. For input signal amplitudes 22-8V, accessing the signal feedly for secommended Connect the N pin a capitactic (1) pin (7 or 0) signal signal ended to the secommended Connect the N pin a capitactic (1) pin (7 or 0) signal pin second signal pin (1) vision second pin and (1) vision second pin (1) vision second pi
12 13	XA XB	A/I	the signal on the driver side of the coupling cap. Crystal or Input Clock Pins Crystal or NPUT Clock Pins Crystal or NPUT Clock Pins Crystal NPUT A Coupling Coupling Coupling Coupling 3.2 for crystal characteristics and recommended external components. 5.2 for crystal characteristics and recommended external components. April Clock MCRQ-XAB = 1.0 a neteral local collistor or clock signal can be comesceded to the XA pin. The XB pin must be lift unconnected. The signa on XA can the as signer as 3.3 Verw new TOPD its on IV.2.
8, 9 6, 5 2, 3 55, 56 53, 52 47, 48 45, 44 41, 40 37, 38 35, 34	OC1P, OC1N OC2P, OC2N OC3P, OC3N OC4P, OC4N OC5P, OC5N OC6P, OC6N OC7P, OC7N OC8P, OC8N OC9P, OC9N OC10P, OC10N	0	Long and the sea sharper as 3 are vern winn't under 1 surg 2.57. Long and the sea of th
29	RSTN	1	Reset (Active Low) When this global asynchronous reset is pulled low, all internal circuitry is rest to default values. The device is held in reset as long as RSTN is low. Minimum low time is 1us.
23 22 28	AC0/GPIO0 AC1/GPIO1 AC2/GPIO2	1/0	Auto-Configure [2:0] / General Purpose I/O 0, 1 and 2 Auto Configure: On the rising edge of RSTN these pins behave as AC[2:0] and specify one of the configurations stored in ROM or EEPROM. See section 5.2.

Pin#	Name	Type	Description
			bidirectional data line between the device and an external I ² C master. In I ² C mode this pin should be externally pulled high by a $1k\Omega$ to $5k\Omega$ resistor.
			SPI MOSI: When the device is configured as a SPI slave, an external SPI master sends commands, addresses and data to the device on MOSI. When the device is configured as a SPI master (21.30260, 21.30262 only), the device sends commands, addresses and data on MOSI to an external SPI EEPROM during auto-configuration.
11,17, 32,42	VDDH	Р	Higher Core Power Supply. 2.5V or 3.3V ±5%. When VDDH=3.3V the device has additional internal power supply regulators enabled.
4,10, 14,31, 33,39, 49,50, 51	VDDL	Р	Lower Core Power Supply, 1.8V ±5% or same voltage as VDDH.
30	VDDIO	P	Digital Power Supply for Non-Clock I/O Pins. 1.8V to VDDH.
7	VDDOA	P	Power Supply for OC1P/N and OC2P/N. 1.5V to VDDH.
1	VDDOB	P	Power Supply for OC3P/N. 1.5V to VDDH.
54	VDDOC	P	Power Supply for OC4P/N and OC5P/N. 1.5V to VDDH.
46	VDDOD	P	Power Supply for OC6P/N and OC7P/N. 1.5V to VDDH.
43	VDDOE	P	Power Supply for OC8P/N. 1.5V to VDDH.
36	VDDOF	P	Power Supply for OC9P/N and OC10P/N. 1.5V to VDDH.
E-pad	VSS	P	Ground. 0 Volts.

Pin#	Name	Туре	Description
			General-Purpose I/O: After reset these pins are GPIO0, GPIO1 and GPIO2. GPIOCR1 and GPIOCR2.GPIO2C configure these pins. Their states are indicated in GPIOSR which has both real-time and latched status bits.
			Note that when the power supply arrangement for the device has VDDL=1.8V, during the interval between VDDH ramping and VDDL ramping these pins can briefly behave as an output driving high.
			Factory Test / General Purpose I/O 3
			Factory Test: On the rising edge of RSTN the pin behaves as TEST. Factory test mode is enabled when TEST is high. Typically TEST should be low on the rising edge of RSTN, but see section 5.2 for some options where TEST can be high on the rising edge of RSTN.
21	TEST/GPIO3	I/O	General-Purpose I/O: After reset this pin is GPIO3. GPIOCR2.GPIO3C configures the pin. It state is indicated in GPIOSR which has both real-time and latched status bits.
			Note that when the power supply arrangement for the device has VDDL=1.8V, during the interval between VDDH ramping and VDDL ramping this pin can briefly behave as an output driving high.
27	IF0/CSN	1/0	Interface Mode 0 / SPI Chip Select (Active Low)
			Interface Mode: On the rising edge of RSTN the pin behaves as IF0 and, together with IF1, specifies the interface mode for the device. See section 5.2.
			SPI Chip Select: After reset this pin is CSN. When the device is configured as a SPI stave, an external SPI naster must assert flow) CSN to access device registers. When the device is configured as a SPI master (Z1,30260, Z1,30262 only), the device asserts CSN to access an external SPI EEPROM during auto-configuration and then changes CSN to an input during normal coperation. CSN should not be allowed to float.
			Interface Mode 1 / SPI Master-In-Slave-Out
	IF1/MISO	1/0	Interface Mode: On the rising edge of RSTN the pin behaves as IF1 and, together with IF0, specifies the interface mode for the device. See section 5.2.
26			SPI MISO. After reset this pin is MISO. When the device is configured as a SPI stave, the device outputs data to an external SPI master on MISO during SPI read transactions. When the device is configured as a SPI master (ZL.3026, ZL.30262 only), the device receives data on MISO from an external SPI EEPROM during auto-configuration.
	SCL/SCLK	1/0	I ² C Clock / SPI Clock
24			$\it PCC$ Clock: When the device is configured as an I^2C slave, an external I^2C master must provide the I^2C clock signal on the SCL pin. In I^2C mode this pin should be externally pulled high by a $ {\rm Tk}\Omega$ to ${\rm Sk}\Omega$ resistor.
			SPI Clock: When the device is configured as a SPI slave, an external SPI master must provide the SPI clock signal on SCLK. When the device is configured as a SPI master (ZL30260, ZL30262 only), the device drives SCLK as an output to clock accesses to an external SPI EEPROM during auto-configuration.
25	SDA/MOSI	1/0	I ² C Data / SPI Master-Out-Slave-In
20	ODAVINIOSI		I ² C Data: When the device is configured as an I ² C slave, SDA is the

TPS22975 - Load switch IC - High-current load switch Control 3.3V power to relays Input voltage range - 0.6V to 5.7V Maximum load current - 6A Loon-resistance Integrated soft-start Fast shutdown



TPS61023 - Boost converter (Step-up regulator)

High-efficiency boost converter - Step up low voltage to higher voltages

Convert VUSB to 5.23V

Output voltage - Adjustable up to 5.5V Maximum output current - 2.4A

High efficiency - Up to 95%

NO.	PIN	IIO		DESCRIPTION	
Pin Func	****	Figur	VIN E	GND se 6-Pin SOT563 Top View	
			EN	sw	
			FB 🗌 🍨	Vout	

5 Pin Configuration and Functions

PIN		IID	DESCRIPTION
NO.	NAME	110	DESCRIPTION
1	FB	- 1	Voltage feedback of adjustable output voltage
2	EN	- 1	Enable logic input. Logic high voltage enables the device. Logic low voltage disables the device and turns it into shutdown mode.
3	VIN	- 1	IC power supply input
4	GND	PWR	Ground pin of the IC
5	sw	PWR	The switch pin of the converter. It is connected to the drain of the internal low-side power MOSFET and the source of the internal high-side power MOSFET.
6	VOUT	PWR	Boost converter output

TPS562202 - Buck converter (Step-down regulator)
Synchronous step-down converter - Reduce high voltages
Convert 12V to 5V
Input voltage - 4.5V to 17V
Output voltage - Adjustable from 0.76V to input voltage
Output current - 2A maximum
Efficiency - Up to 95%

FE_EN / ACO_EN - Enable control signal Enable signal for controlling power sections FE_EN (Front-end enable) Control power to the front-end analog circuitry

ACO_EN (Acquisition enable) Enable power switch (TPS22975) to activate relays or acquisition circuits

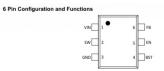


Figure 6-1. 6-Pin SOT563 DRL Package (Top V	iew
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PIN			DESCRIPTION	
NAME	NO.	1/0	DESCRIPTION	
VIN	1	- 1	Input voltage supply pin	
SW	2	0	Switch node connection between high-side NFET and low-side NFET	
GND	3	1-1	Ground pin source terminal of low-side power NFET as well as the ground terminal for controller circuit. Connect sensitive FB to this GND at a single point.	
BST	4	0	Supply input for the high-side NFET gate drive circuit. Connect 0.1-µF capacitor between BST and SW pin.	
EN	5	- 1	Enable input control. Active high. Must be pulled up to enable the device.	
FR	6	1	Converter feedback input. Connect to output voltage with feedback resistor divider.	

